Status of AstroPix chip QC preparation

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Overview

Probe card design for V3

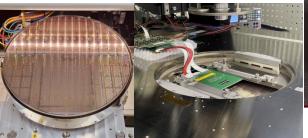
- Initial discussion with NOTICE based on the design file
- Still under discussion about details

AstroPix V3 lab test

- Recently, successful operation with the up-to-date A-STEP firmware and software
- Wafer probing for wafer-level test
 - Under discussion with the ALICE ITS3 team and several wafer-probing companies in Korea to test ALICE ITS3 ER1 wafer
- Single-chip test machine
 - Initial design for a prototype from C-ON tech
 - Machine validation will be done with ALPIDE, then move to AstroPix



AstroPix V3 lab test setup



ALICE ITS3 ER1 wafer probing



Probe card for ALPIDE



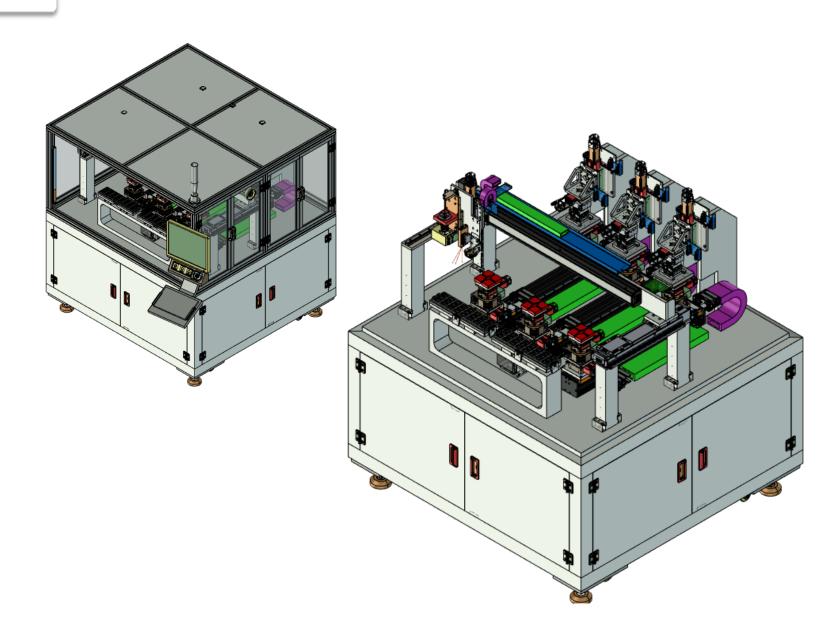
Probe Test System

2024.09



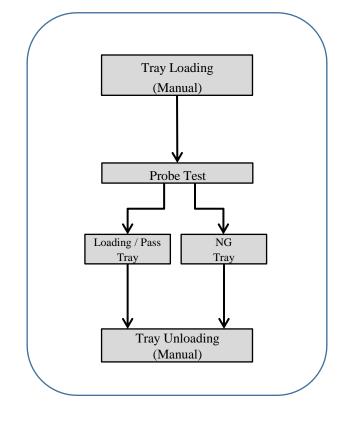
Introduction to Equipment

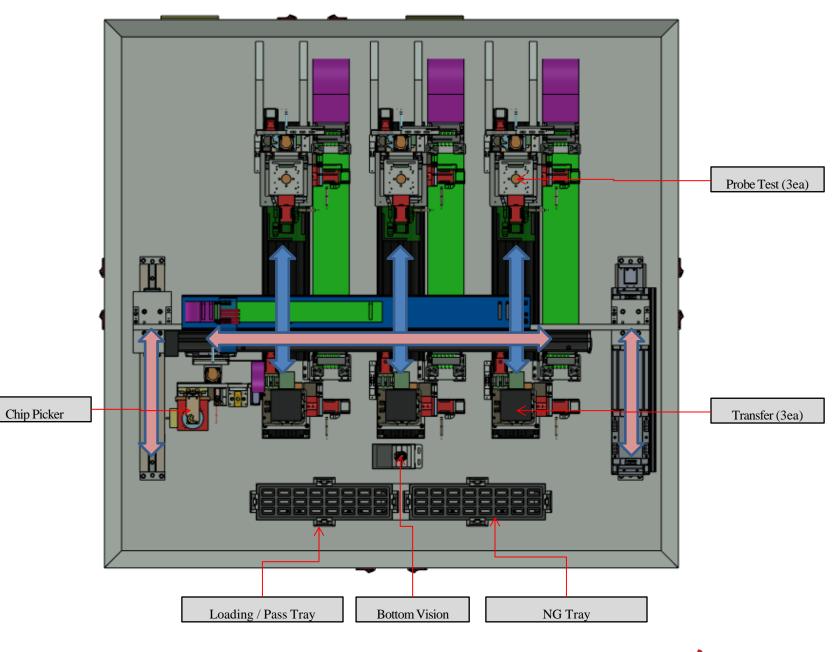
- Description
- Probe Test System
- Tray Loading : Manual
- Probe Test Motion : Z Axis Servo Motor
- Chip Picker Motion : X,Y,Z Axis Servo Motor
- Transfer Motion : YAxis Servo Motor
- Vision: Dispensing Align Top/Bottom Vision





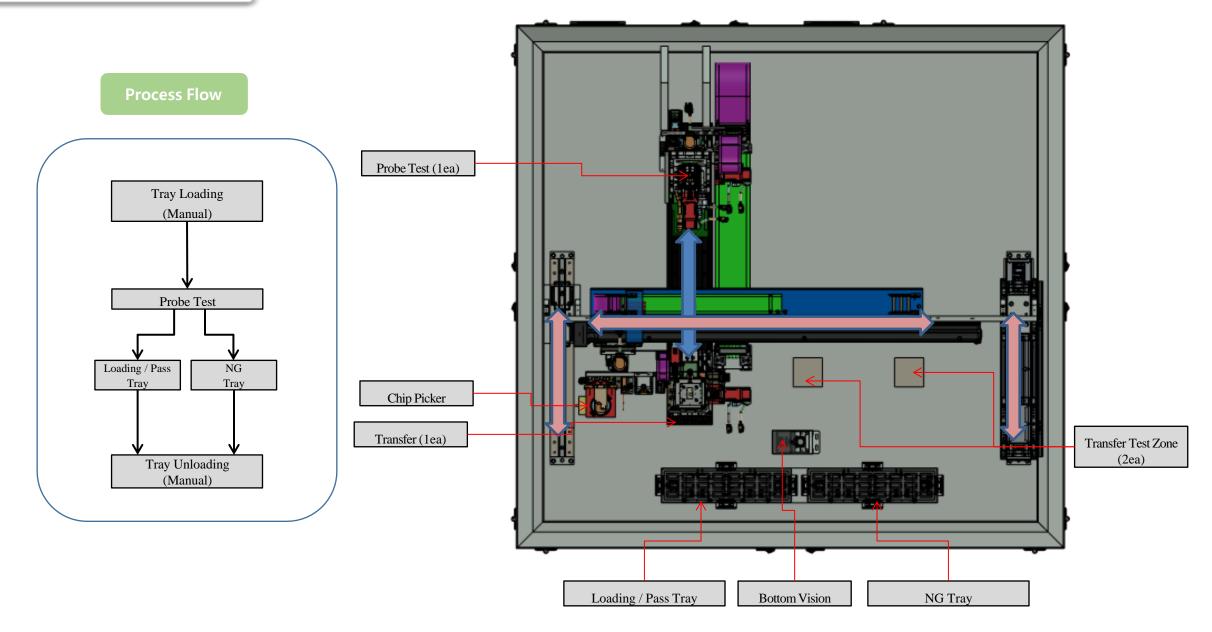
Process Flow (A TYPE) Process Flow



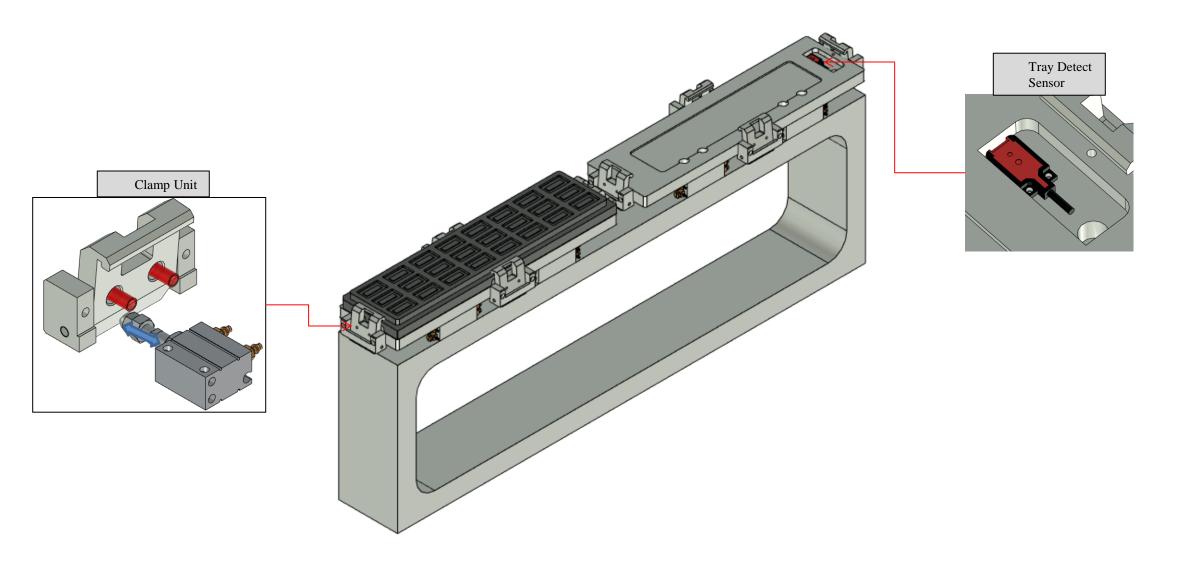




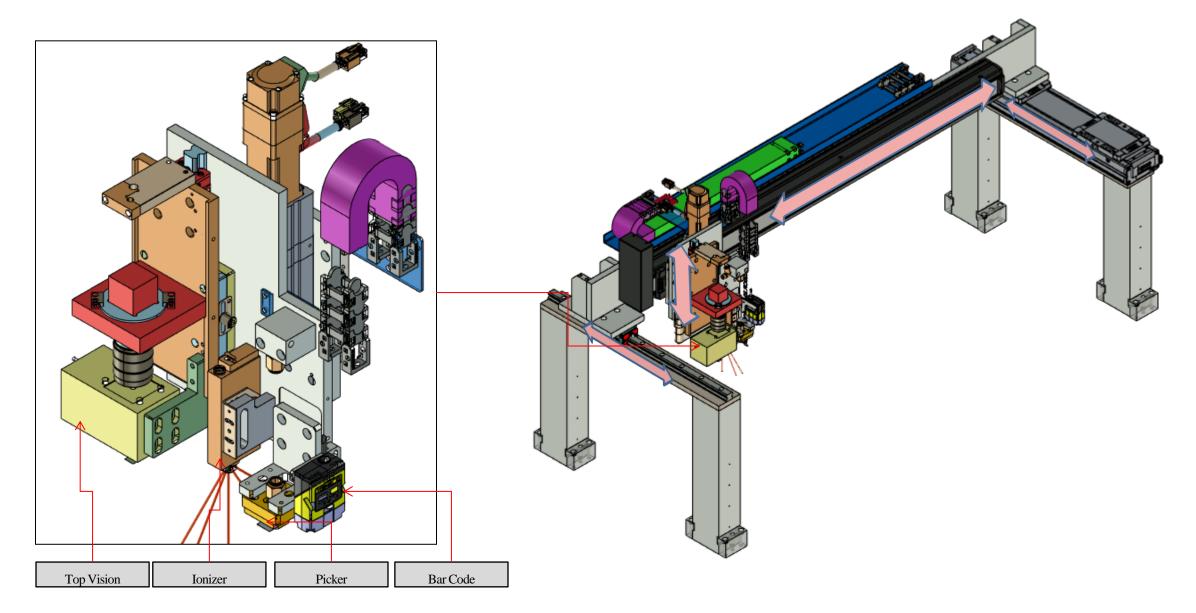
Process Flow (B TYPE)

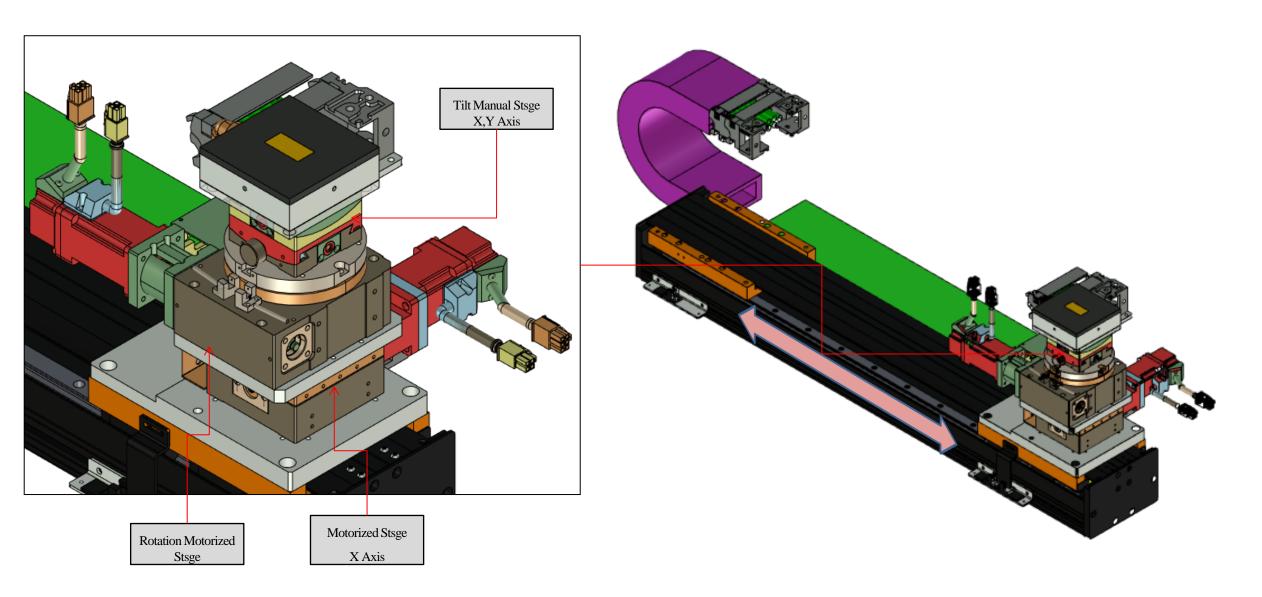


Tray Loading



Chip Picker





Probe Test (3ea)

Stsge

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